

**Search Notes**

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10/802,786

Examiner

Thien F. Tran

Applicant(s)/Patent under  
Reexamination

HONMA ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
257	295, 296	2/3/2005	TT
257	306, 310	2/3/2005	TT
438	254, 397	2/4/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR